

UNITED STATES PATENT AND TRADEMARK OFFICE



UNITED STATES DEPARTMENT OF COMMERCE United States Patent and Trademark Office Address: COMMISSIONER FOR PATENTS P.O. Box 1450 Alexandria, Virginia 22313-1450 www.uspto.gov

APPLICATION NO.	FILING DATE	FIRST NAMED INVENTOR	ATTORNEY DOCKET NO.	CONFIRMATION NO.
10/760,458	01/21/2004	Taikan Iinuma	OKI.603	1405
20987 75	590 07/06/2005	EXAMINER		
	FRANCOS, & WHITT	WILSON, CH	WILSON, CHRISTIAN D	
ONE FREEDOM SQUARE 11951 FREEDOM DRIVE SUITE 1260 RESTON, VA 20190			ART UNIT	PAPER NUMBER
			2891	
			DATE MAILED: 07/06/2009	5

Please find below and/or attached an Office communication concerning this application or proceeding.

· · · · · · · · · · · · · · · · · · ·		Application No.	Applicant(s)				
Office Action Summary		10/760,458	IINUMA, TAIKAN	IINUMA, TAIKAN			
		Examiner	Art Unit				
		Christian Wilson	2891				
The MAILING DATE of this communication appears on the cover sheet with the correspondence address Period for Reply							
THE - External after - If the - If NO - Failur Any I	ORTENED STATUTORY PERIOD FOR RIMAILING DATE OF THIS COMMUNICATIOnsions of time may be available under the provisions of 37 CF SIX (6) MONTHS from the mailing date of this communication period for reply specified above is less than thirty (30) days, period for reply is specified above, the maximum statutory per to reply within the set or extended period for reply will, by steply received by the Office later than three months after the red patent term adjustment. See 37 CFR 1.704(b).	ON. FR 1.136(a). In no event, however, may and and and and and are ply within the statutory minimum of the ariod will apply and will expire SIX (6) MO statute, cause the application to become A	reply be timely filed irty (30) days will be considered timely NTHS from the mailing date of this co ABANDONED (35 U.S.C. § 133).				
Status	·						
1)	Responsive to communication(s) filed on _						
2a)□	a) ☐ This action is FINAL . 2b) ☑ This action is non-final.						
3)[3) Since this application is in condition for allowance except for formal matters, prosecution as to the merits is						
	closed in accordance with the practice under Ex parte Quayle, 1935 C.D. 11, 453 O.G. 213.						
Dispositi	ion of Claims						
4)⊠ Claim(s) <u>1-6</u> is/are pending in the application.							
	4a) Of the above claim(s) is/are withdrawn from consideration.						
· · · · · · · · · · · · · · · · · · ·	5) Claim(s) is/are allowed.						
	6) Claim(s) <u>1-6</u> is/are rejected.						
	☐ Claim(s) is/are objected to. ☐ Claim(s) are subject to restriction and/or election requirement.						
ات (۵	Claim(s) are subject to restriction a	nu/or election requirement.					
Applicati	on Papers						
9) The specification is objected to by the Examiner.							
10)⊠ The drawing(s) filed on <u>21 January 2004</u> is/are: a)⊠ accepted or b)□ objected to by the Examiner.							
	Applicant may not request that any objection to the drawing(s) be held in abeyance. See 37 CFR 1.85(a).						
Replacement drawing sheet(s) including the correction is required if the drawing(s) is objected to. See 37 CFR 1.121(d). 11) The oath or declaration is objected to by the Examiner. Note the attached Office Action or form PTO-152.							
				·			
	ınder 35 U.S.C. § 119						
•	Acknowledgment is made of a claim for for	eign priority under 35 U.S.C.	§ 119(a)-(d) or (f).				
a)[a)⊠ All b)□ Some * c)□ None of:						
	 1. ☐ Certified copies of the priority documents have been received. 2. ☐ Certified copies of the priority documents have been received in Application No 						
	3. Copies of the certified copies of the		• • • • • • • • • • • • • • • • • • • •	Stage			
	application from the International Bu	•		-			
* S	See the attached detailed Office action for a	list of the certified copies no	t received.				
Attachmen	Ne)						
1) Notice of References Cited (PTO-892) 4) Interview Summary (PTO-413)							
2) Notice of Draftsperson's Patent Drawing-Review (PTO-948) Paper No(s)/Mail Date 3) Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) 5) Notice of Informal Patent Application (PT							
3) ☑ Information Disclosure Statement(s) (PTO-1449 or PTO/SB/08) Paper No(s)/Mail Date <u>01212004</u> . 5) ☐ Notice of Informal Patent Application (PTO-152) 6) ☑ Other: <u>search history</u> .							

Application/Control Number: 10/760,458

Art Unit: 2891

DETAILED ACTION

Claim Rejections - 35 USC § 103

- 1. The following is a quotation of 35 U.S.C. 103(a) which forms the basis for all obviousness rejections set forth in this Office action:
 - (a) A patent may not be obtained though the invention is not identically disclosed or described as set forth in section 102 of this title, if the differences between the subject matter sought to be patented and the prior art are such that the subject matter as a whole would have been obvious at the time the invention was made to a person having ordinary skill in the art to which said subject matter pertains. Patentability shall not be negatived by the manner in which the invention was made.
- 2. Claims 1 3 and 6 are rejected under 35 U.S.C. 103(a) as being unpatentable over Park et al. in view of Noguchi.

Park et al. (US 6,465,866) teaches a method of manufacturing a semiconductor device comprising the steps of forming a groove 47 extending from a main surface of a substrate 40 to an intermediate depth [Figure 5B], forming a first thermal oxide film 48 by wet oxidation over a bottom surface of the grove to an intermediate point on the sidewall of the groove [Figure 5C], and forming a second thermal oxide film 54 extending from the intermediate point to over the main surface of the substrate [Figure 5F]. Park et al. teaches a second thermal oxide film but does not discuss the oxidation process. Noguchi (US 6,548,866) a second thermal oxide film formed by dry oxidation [column 15, lines 50-55]. It would have been obvious to one of ordinary skill in the art to use the dry oxidation method of Noguchi in the method of Park et al. since Noguchi teaches that dry oxidation prevents the formation of a bird's beak and a smaller tilt surface at the side of the trench.

Regarding claim 2, Park et al. further teaches forming the groove by patterning using a mask 44 exposing a region of the surface of the substrate and etching using the mask [Figure 5A], forming a pre-first thermal oxide film extending out of the groove and forming an etch

Application/Control Number: 10/760,458

Art Unit: 2891

resistant film 50 covering the pre-first thermal oxide film, performing a second etching to selectively remove the pre-first thermal oxide film extending out of the groove [Figure 5E], and forming the second thermal oxide film while leaving the etch resistant film as an antioxidation film [Figure 5F].

Regarding claim 3, Park *et al.* further teaches prior to the second etching polishing the etch resistant film to expose the pre-first thermal oxide film [Figure 5D].

Regarding claim 6, Park et al. further teaches an etching solution containing HF acid [column 6, lines 55-56].

3. Claim 4 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park *et al.* and Noguchi as applied to claim 1 above, and further in view of Kim *et al.*

Park et al. as modified by Noguchi teaches the limitations of claim 1 as described above including filling the groove [Figure 5D] and polishing the insulating film 52, but they do not discuss forming a protection film on the second thermal oxide before filling the groove. Kim et al. (US 2002/0117731) teaches forming a protection layer 314 before filling the groove. It would have been obvious to one of ordinary skill in the art to form a protection layer in the method of Park et al. since the protection layer alleviates the stress on the inner wall of the trench [0052].

4. Claim 5 is rejected under 35 U.S.C. 103(a) as being unpatentable over Park *et al.* and Noguchi as applied to claim 1 above, and further in view of Chang *et al.*

Park et al. as modified by Noguchi teaches the limitations of claim 1 as described above, but they do not discuss the temperature ranges of the dry and wet oxidation methods. Chang et al. (US 6,566,224) teaches a dry and wet oxidation method where the wet oxidation temperature is lower than the temperature of the dry oxidation and the temperature ranges from 950 °C to 1100 °C [column 5, lines 10-20]. It would have been obvious to one of ordinary skill in the art

Art Unit: 2891

to use the temperature ranges of Chang et al. in the method of Park et al. since these temperatures are advantageous for forming equivalent oxide thicknesses with reduced sharp corners and leakage current.

Conclusion

- 5. A copy of the search history is enclosed.
- 6. Any inquiry concerning this communication or earlier communications from the examiner should be directed to Christian Wilson whose telephone number is (571) 272-1886. The examiner can normally be reached on weekdays, 7:30 AM to 4 PM.

If attempts to reach the examiner by telephone are unsuccessful, the examiner's supervisor, Bill Baumeister can be reached on (571) 272-1722. The fax phone number for the organization where this application or proceeding is assigned is 703-872-9306.

Information regarding the status of an application may be obtained from the Patent Application Information Retrieval (PAIR) system. Status information for published applications may be obtained from either Private PAIR or Public PAIR. Status information for unpublished applications is available through Private PAIR only. For more information about the PAIR system, see http://pair-direct.uspto.gov. Should you have questions on access to the Private PAIR system, contact the Electronic Business Center (EBC) at 866-217-9197 (toll-free).

Christian Wilson, Ph.D. Primary Examiner

Art Unit 2891